

Notice of References Cited	Application/Control No. 10/790,823		Applicant(s)/Patent Under Reexamination YOSHIDA, HISASHI	
	Examiner (Nancy) Thanh-Nhan P. Nguyen		Art Unit 2871	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,624,860	09-2003	Narutaki et al.	349/106
*	B	US-2006/0103794	05-2006	Iijima et al.	349/114
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	T	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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